



SIGC12T60SNC

IGBT Chip in NPT-technology

FEATURES:

- 600V NPT technology
- 100µm chip
- short circuit prove
- positive temperature coefficient
- easy paralleling

This chip is used for:

• SGP10N60

Applications:



Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code
SIGC12T60SNC	600V	10A	3.5 x 3.5 mm ²	sawn on foil	Q67041-A4664- A001
SIGC12T60SNC	600V	10A	3.5 x 3.5 mm ²	unsawn	Q67041-A4664- A002

MECHANICAL PARAMETER:

Raster size	3.5 x 3.5			
Area total / active	12.25 / 8.7			
Emitter pad size	1.99 x 1.58			
Gate pad size	1.1 x 0.694			
Thickness	100	μm		
Wafer size	150	mm		
Flat position	270	deg		
Max.possible chips per wafer	1219			
Passivation frontside	Photoimide			
Emitter metallization	3200 nm Al Si 1%			
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding			
Die bond	electrically conductive glue or solder			
Wire bond	Al, ≤500μm			
Reject Ink Dot Size	Ø 0.65mm; max 1.2mm			
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C			



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MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V _{CE}	600	V
DC collector current, limited by T _{jmax}	I _C	21	А
Pulsed collector current, t _p limited by T _{jmax}	I _{cpuls}	42	А
Gate emitter voltage	V _{GE}	±20	V
Operating junction and storage temperature	T_j , T_{stg}	-55 + 150	°C

STATIC CHARACTERISTICS (tested on chip), T_j =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
Turumeter		Conditions	min.	typ.	max.	
Collector-emitter breakdown voltage	V _{(BR)CES}	V_{GE} =0V, I_{C} =500 μ A	600			
Collector-emitter saturation voltage	V _{CE(sat)}	V_{GE} =15V, I_{C} =10A	1.6	2	2.5	V
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	$I_C=300\mu A,\ V_{GE}=V_{CE}$	3	4	5	
Zero gate voltage collector current	I _{CES}	V_{CE} =600V, V_{GE} =0V			40	μA
Gate-emitter leakage current	I _{GES}	V_{CE} =0V, V_{GE} =30V			100	nA

DYNAMIC CHARACTERISTICS (tested at component):

Parameter	Symbol	Conditions	Value			Unit
rarameter	Symbol	Conditions	min.	typ.	max.	Ullit
Input capacitance	Ciss	V _{CE} =25V	-	580	696	pF
Output capacitance	Coss	$V_{GE}=0V$	-	70	84	
Reverse transfer capacitance	Crss	f=1MHz	-	50	60	

SWITCHING CHARACTERISTICS (tested at component), Inductive Load:

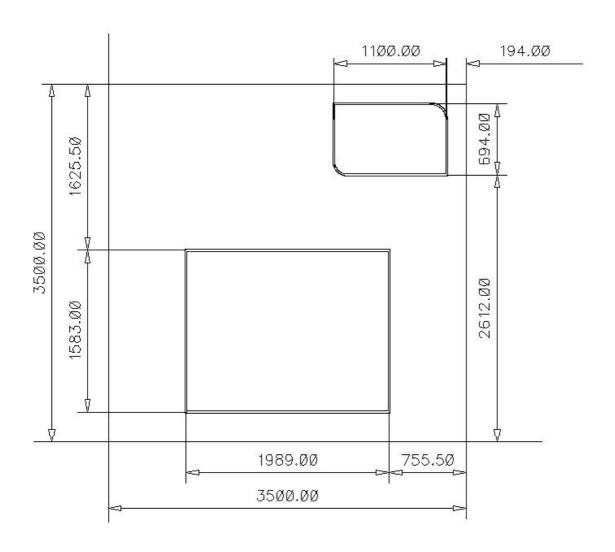
Parameter	Symbol	Conditions*	Value			Unit
- and annexe	Symbol	Conditions	min.	typ.	max.	Offic
Turn-on delay time	$t_{d(on)}$	$T_{\rm j}$ =150°C $V_{\rm CC}$ =400V	-	29	35	ns
Rise time	t _r	$I_{\rm C}$ =10A	-	21	25	
Turn-off delay time	$t_{d(off)}$	$V_{\rm GE}$ =+15/0V $R_{\rm G}$ =25 Ω	•	266	319	
Fall time	t _f	//G-2032	-	63	76	

^{*} switching conditions different to 600V LowLoss, under comparable switching conditions 40% faster turnoff than LowLoss



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CHIP DRAWING:





Preliminary

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FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet SGP10N60 Package :TO220

Description:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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